Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/524,575	HIRAMATSU ET AL.	
Examiner	Art Unit	
Hien Tran	1764	

SEARCHED					
Class	Subclass	Date	Examiner		
422	170-171, 173,177, 180,211, 222	1/17/2003	нт		
60	297,299,	1/17/2003	нт		
60	300	1/17/2003	нт		
updated	search	6/29/2003	нт		
updated	search	10/13/2004	нт		
updated	search	11/15/2004	нт		
updated	search	5/25/2005	нт		
updated	search	1/26/2006	нт		
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INTERFERENCE SEARCHED					
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
checked parent application 08/726,468	1/17/2003	нт
East Image class/subclass search / Inventors' names search	10/13/2004	нт
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